

P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary (Typ @ $V_{GS} = -4.5V$, $T_A = +25$ °C)

BV _{DSS}	R _{DS(ON)}	Qg	Q_{gd}	ΙD
-12V	65mΩ	9nC	2.4nC	-3.2A

Features and Benefits

- Built-in G-S Protection Diode against ESD 2kV HBM
- Ultra Small 0.8mm x 0.8mm Package
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Description and Applications

This new generation MOSFET is designed to minimize the onstate resistance $(R_{\text{DS(ON)}})$ and yet maintain superior switching performance, making it ideal for high-efficiency power management applications. It is a high-performance MOSFET in ultra-small 0.8mm x 0.8mm package.

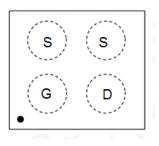
- Portable Applications
- Load Switch
- Power Management Functions

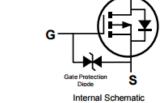
Mechanical Data

Case: X2-WLB0808-4

- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- UBM Opening: 203µm







Top View

Ordering Information (Note 4)

Part Number	Case	Packaging
DMP1100UCB4-7	X2-WLB0808-4	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



9W = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: D = 2016) M or \overline{M} = Month (ex: 9 = September)

Date Code Key

Year	201	6	2017		2018	20	19	2020		2021	2	2022
Code	D		E		F	(3	Н				J
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	V_{DSS}	-12	V	
Gate-Source Voltage	V _{GSS}	±8	V	
Continuous Source Current @ V _{GS} = -4.5V (Note 5)	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	-2.5 -2.0	А
Continuous Source Current @ V _{GS} = -4.5V (Note 6)	$T_A = +25$ °C $T_A = +70$ °C	I _D	-3.2 -2.6	А
Pulsed Drain Current (Pulse Duration 10µs, Duty Cycle ≤1%	I _{DM}	-13	A	
Continuous Source-Drain Diode Current	I _S	-1.2	Α	

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P _D	0.67	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ heta JA}$	187	°C/W
Total Power Dissipation (Note 6)	P _D	1.1	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{ heta JA}$	117	°C/W
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 7)								
Drain-Source Breakdown Voltage	BV _{DSS}	-12	-	-	V	$V_{GS} = 0V, I_{D} = -250\mu A$		
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-1	μΑ	$V_{DS} = -12V, V_{GS} = 0V$		
Gate-Body Leakage	I _{GSS}	-	-	±10	μΑ	$V_{GS} = \pm 8V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 7)								
Gate Threshold Voltage	V _{GS(TH)}	-0.35	-0.55	-0.8	V	$V_{DS} = V_{GS}$, $ID = -250 \mu A$		
Static Drain-Source On-Resistance	R _{DS(ON)}	-	65 80 90 115 135	83 96 150 170 300 400	mΩ	$V_{GS} = -4.5V, I_D = -3A$ $V_{GS} = -2.5V, I_D = -2A$ $V_{GS} = -1.8V, I_D = -1A$ $V_{GS} = -1.5V, I_D = -1A$ $V_{GS} = -1.4V, I_D = -1A$ $V_{GS} = -1.3V, I_D = -1A$		
Forward Transfer Admittance	Y _{fs}	-	6.5	-	S	$V_{DS} = -4V, I_{S} = -1.5A$		
Body Diode Forward Voltage	V_{SD}	-	-0.7	-	V	$V_{GS} = 0V, I_{S} = -1.5A,$		
DYNAMIC CHARACTERISTICS (Note 8)								
Input Capacitance	C _{iss}	-	680	820	pF	$V_{DS} = -6V, V_{GS} = 0V,$		
Output Capacitance	Coss	-	220	290	pF	$V_{DS} = -6V, V_{GS} = 6V,$ - f = 1.0MHz		
Reverse Transfer Capacitance	C_{rss}	-	205	280	pF	1 = 1.01/11/12		
Gate Resistance	R_g	-	11.2	17	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$		
Total Gate Charge	Q_g	-	9.0	14	nC	$V_{GS} = -4.5V, V_{DS} = -6V,$		
Gate-Source Charge	Q_gs	-	1.0	-	nC	$V_{GS} = -4.5V, V_{DS} = -6V,$ - $I_{D} = -2A$		
Gate-Drain Charge	Q_gd	-	2.6	-	nC	10 = 27		
Turn-On Delay Time	t _{D(ON)}	-	4.4	9	ns			
Turn-On Rise Time	t _R	-	10.1	-	ns	$V_{DD} = -4V$, $I_D = -2A$		
Turn-Off Delay Time	t _{D(OFF)}	-	22	33	ns	$V_{GEN} = \text{-}4.5 \text{V}, \; R_g = 1 \Omega, \; R_L = 3 \Omega$		
Turn-Off Fall Time	t _F	=	20	-	ns			

Notes:

- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 Short duration pulse test used to minimize self-heating effect.



Electrical Characteristics (@T_A = 0°C.)

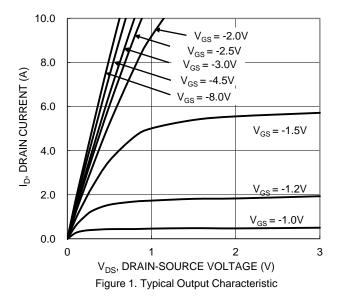
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
ON CHARACTERISTICS (Note 7,Note 8)						•
Static Drain-Source On-Resistance	R _{DS(ON)}	-	62 78 88 112 130 150	83 96 150 170 300 400	mΩ	V _{GS} = -4.5V, I _D = -3A V _{GS} = -2.5V, I _D = -2A V _{GS} = -1.8V, I _D = -1A V _{GS} = -1.5V, I _D = -1A V _{GS} = -1.4V, I _D = -1A V _{GS} = -1.3V, I _D = -1A

Electrical Characteristics (@T_A = + 65°C.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
ON CHARACTERISTICS (Note 7,Note 8)						
Static Drain-Source On-Resistance	R _{DS(ON)}	-	73 89 107 127 141 163	93 118 185 195 300 400	mΩ	V _{GS} = -4.5V, I _D = -3A V _{GS} = -2.5V, I _D = -2A V _{GS} = -1.8V, I _D = -1A V _{GS} = -1.5V, I _D = -1A V _{GS} = -1.4V, I _D = -1A V _{GS} = -1.3V, I _D = -1A

Note: 8. Guaranteed by design. Not subject to production testing.





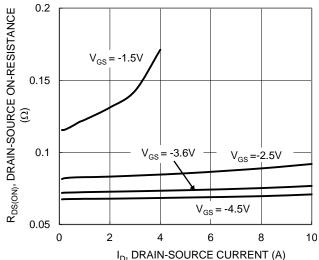


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

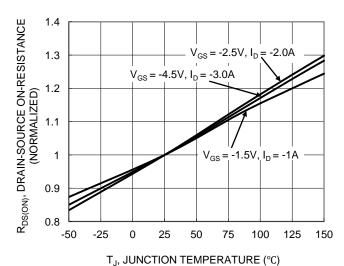


Figure 5. On-Resistance Variation with Junction
Temperature

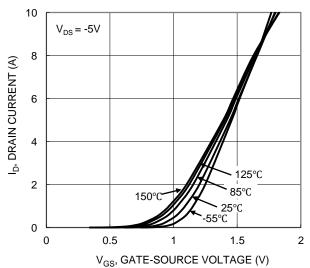


Figure 2. Typical Transfer Characteristic

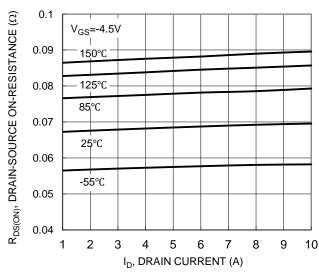
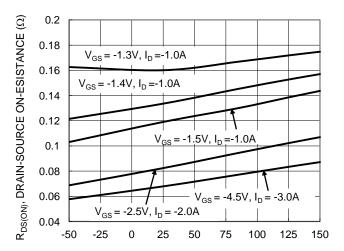


Figure 4. Typical On-Resistance vs. Drain Current and Junction Temperature



T_J, JUNCTION TEMPERATURE (°C) Figure 6. On-Resistance Variation with Junction Temperature



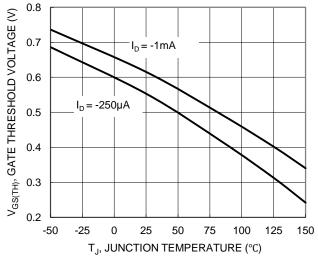
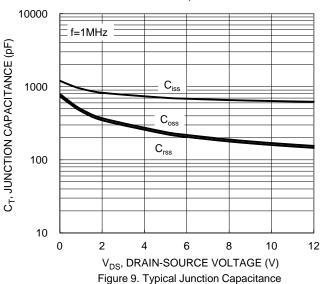


Figure 7. Gate Threshold Variation vs. Junction Temperature



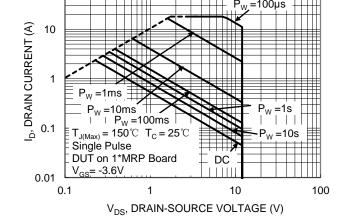
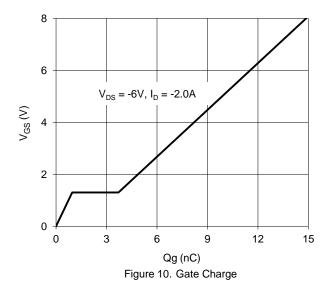


Figure 11. SOA, Safe Operation Area

10 $V_{GS} = 0V$ Is, SOURCE CURRENT (A) 8 6 4 T₁ = 85°C $T_{J} = 125^{\circ}C$ $T_J = 25^{\circ}C$ 2 T_J = 150°C $T_1 = -55^{\circ}C$ 0 0 0.3 0.6 0.9 1.2 1.5 V_{SD} , SOURCE-DRAIN VOLTAGE (V)

Figure 8. Diode Forward Voltage vs. Current



400 Single Pulse P_(pk), PEAK TRANSIENT POWER (W) $R_{\theta JA} = 187^{\circ}C/W$ $R_{\theta JA}^{\theta JA}(t)=R_{\theta JA} * r(t)$ 300 200 100 0 1E-050.0001 0.001 0.01 0.1 1 10 100 1000 t₁, PULSE DURATION TIME (sec)

Figure 12. Single Pulse Maximum Power Dissipation

100

R_{DS(ON)} Limited



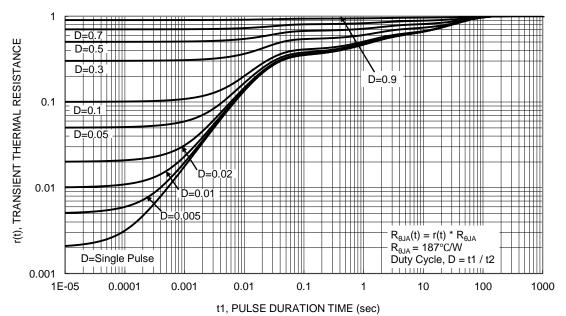


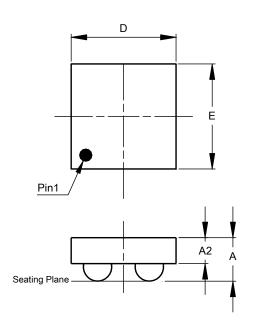
Figure 13. Transient Thermal Resistance

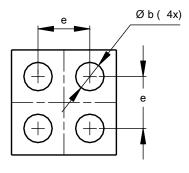


Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-WLB0808-4



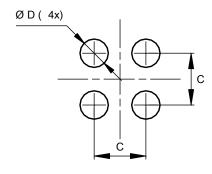


	X2-WLB0808-4							
Dim	Min	Max	Тур					
Α		0.400	0.375					
A2			0.180					
b	0.1971	0.2409	0.219					
D	0.790	0.820	0.816					
Е	0.790	0.820	0.816					
е			0.400					
All	Dimens	sions in	mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-WLB0808-4



Dimensions	Value (in mm)
С	0.400
D	0.219



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